



JCO Rec'd PCT/PTO 21 FEB 2002

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

LEIBER, J. et al.

Atty. Ref.: 35-222

Serial No. 10/030,472

Group:

Filed: Unknown

Examiner:

For: DATA STORAGE MEDIUM

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February 21, 2002

Assistant Commissioner for Patents
Washington, DC 20231

Sir:

INFORMATION DISCLOSURE STATEMENT

Attention is invited to the attached documents cited in the International Search Report and the parallel German proceedings. A completed Form PTO-1449 is attached

The internet article "SHIP September 1998, p. 194 (Computer Journal, Munich, Germany) includes only a cover sheet and contents of the paper copy8. Counsel is advised the article starting on page 194 includes a summary of German utility model 298 16 802 which is also identified and discussed on page 1 of the specification of the subject application. The U.S. application corresponding to the utility model is SerialNo. 09/787,099 filed May 9, 2001 now pending in Art Unit 2876.

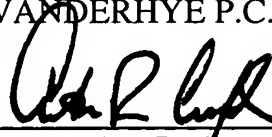
Official citation and consideration of all the attached documents is requested. Please return to the undersigned a copy of the attached PTO-1449 with the examiner's initials in the left column [MPEP §609] with the next communication.

LEIBER, J. et al.
Serial No. 10/030,472

Respectfully submitted,

NIXON & VANDERHYE P.C.

By: _____



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INFORMATION DISCLOSURE CITATION

ATTY. DOCKET NO.

SERIAL NO.

35-222

10/030,472

APPLICANT

LEIBER, J. et al.

(Use several sheets if necessary)

FILING DATE

GROUP

Unknown

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

	Franke Applied Optics Vol. 23, No. 16, 8/1984 pp. 2729-2733 Optical recording of refractive-index patterns in doped poly-(methyl methacrylate) films
	CHIP September 1998, p. 194 (Computer Journal, Munich Germany)

*Examiner

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.